

60V N-Channel MOSFET

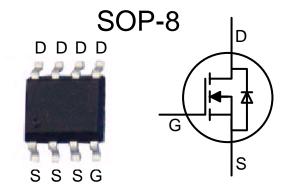
General Features

- Fast Switching Speed
- > RoHS Compliant
- ➤ Halogen-free available

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- Power Management in Inverter System
- > Synchronous Rectification

$\mathbf{BV}_{\mathbf{DSS}}$	R _{DS(ON)} (Typ.)	I_D
60V	8.5m Ω	20A



Ordering Information

Part Number	Package	Marking	Remark
FTE08N06G	SOP-8	08N06G	Halogen Free

Absolute Maximum Ratings

T_A=25°C unless otherwise specified

Symbol	Paramete	Rating	Unit	
$V_{ m DSS}$	Drain-Source Voltage ^[1]		60	V
V_{GS}	Gate –Source Voltage		<u>+25</u>	V
T	I_D Continuous Drain Current $T_{C=25 \ C}$ $T_{C=100 \ C}$		20	A
\mathbf{I}_{D}			14	A
I_{DP}	300us Pulsed Drain Current	40	A	
D	Power Dissipation		5.2	W
P_{D}	Derating Factor above 25 °C		0.04	W/°C
T_J and T_{STG}	Operating and Storage Temp	perature Range	-55 ~ 150	${\mathbb C}$

^{*}Drain Current limited by Maximum Junction Temperature.

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	Rating	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	24	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient	85	C/W



Electrical Characteristics

OFF Characteristics(TA=25 °C unless otherwise noted)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV_{DSS}	Drain-Source Breakdown Voltage	60	1	1	V	V_{GS} =0V, I_{D} =250 μ A
I_{DSS}	Zero Gate Voltage Drain Current			1	μA	$V_{DS}=48V, V_{GS}=0V,$
I _{GSS} Gate Leakage Current			100	nA	$V_{GS}=20V, V_{DS}=0V$	
	Gate Leakage Current			-100	nA	V_{GS} =-20V, V_{DS} =0V

On Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Drain-Source On-Resistance ^[3]		8.5	10	mΩ	$V_{GS}=10V, I_{D}=20A$
V _{GS(TH)}	Gate Threshold Voltage	2		4	V	$V_{\mathrm{DS}} = V_{\mathrm{GS}},I_{\mathrm{D}} = 250\mu\mathrm{A}$
GFS	Forward Transconductance				S	V _{DS} =30V, I _D =20A

Dynamic Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R_{G}	Gate Resistance		1.6		Ω	V_{GS} =0V, V_{DS} =0V, f=1MHz
C_{iss}	Input Capacitance					
C_{oss}	Output Capacitance				pF	$ m V_{GS}$ =0V, $ m V_{DS}$ =30V, f=1MHz
C_{rss}	Reverse Transfer Capacitance					
Q_{g}	Total Gate Charge					
Q_{gs}	Gate-Source Charge				nC	$V_{DS}=30V, V_{GS}=10V,$ $I_{D}=20A$
Q_{gd}	Gate-Drain Charge					D -

Resistive Switch Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
t _{d(on)}	Turn-On Delay Time	1	1			
$t_{\rm r}$	Turn-On Rise Time					$V_{DD}=50V,R_L=30\Omega$
t _{d(off)}	Turn-Off Delay Time				ns	$I_{D}=20.0A, V_{GS}=10V$ $R_{G}=6\Omega$
t_{f}	Turn-Off Fall Time					



Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
I_{SD}	Continuous Source Current(Body Diode)			20	A	Integral P-N diode in
I_{SM}	Maximum Pulsed Current(Body Diode)		1	40	A	MOSFET
V_{SD}	Diode Forward Voltage			1.3	V	$I_{SD} = 20A, V_{GS} = 0V$
t _{rr}	Reverse Recovery Time				ns	I _{SD} =20A,
Q _{rr}	Reverse Recovery Charge				nC	$dI_{SD}/dt=100A/\mu A$

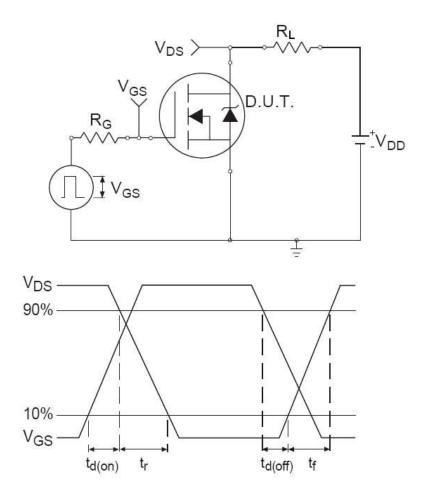
NOTE:

^[1] $T_J = +25^{\circ}C$ to $+150^{\circ}C$

^[2] Repetitive rating, pulse width limited by maximum junction temperature. [3] Pulse width \(\frac{3}{80} \) \(\text{µs;} \) duty cycle \(\frac{2}{8} \).



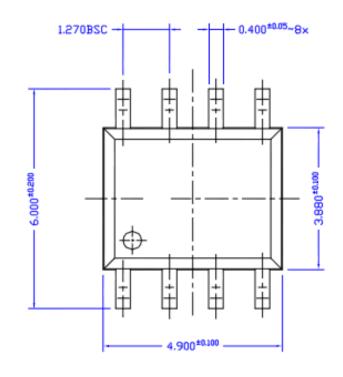
Switching Time Test Circuit and Waveforms

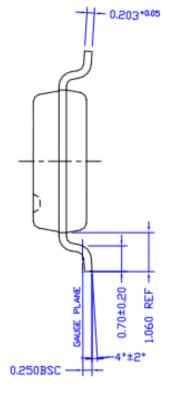


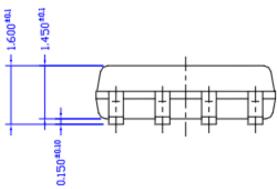


Package Dimensions

SOP-8









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